Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/897,742	KWAK, EUN-JUN
Examiner	Art Unit

Colin M. LaRose

2624

SEARCHED					
Class	Subclass	Date	Examiner		
382	203 284	6/28/2004	JC		
update	above	3/24/2006	CML		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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	ext search ched	3/24/2006	CML	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
IEEE Xplore (printout)	6/25/2004	JC		
EAST (printout)	6/25/2004	JC		
inventor name search	3/24/2006	CML		
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